



## Description

The DMT35M4LFVW-7 use advanced SGT MOSFET technology to provide low  $R_{DS(ON)}$ , low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness.

## General Features

$V_{DS} = 30V$   $I_D = 40A$

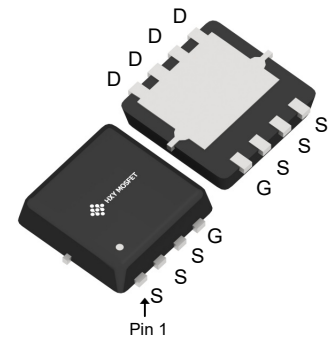
$R_{DS(ON)} < 6.3m\Omega @ V_{GS}=10V$

## Applications

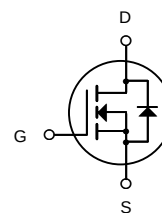
Consumer electronic power supply Motor control

Synchronous-rectification Isolated DC

Synchronous-rectification applications



DFN3X3-8L



N-Channel MOSFET

## Ordering Information

| Product ID    | Pack      | Brand      | Qty(PCS) |
|---------------|-----------|------------|----------|
| DMT35M4LFVW-7 | DFN3X3-8L | HXY MOSFET | 5000     |

## Absolute Maximum Ratings (Tc=25°C unless therwise specified)

| Symbol                  | Parameter                                        | Rating     | Units |
|-------------------------|--------------------------------------------------|------------|-------|
| $V_{DS}$                | Drain-Source Voltage                             | 30         | V     |
| $V_{GS}$                | Gate-Source Voltage                              | $\pm 20$   | V     |
| $I_D @ T_C=25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V^1$       | 40         | A     |
| $I_D @ T_C=100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$       | 28         | A     |
| $I_D @ T_A=25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V^1$       | 27         | A     |
| $I_D @ T_A=70^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V^1$       | 24         | A     |
| $I_{DM}$                | Pulsed Drain Current <sup>2</sup>                | 135        | A     |
| EAS                     | Single Pulse Avalanche Energy <sup>3</sup>       | 29.8       | mJ    |
| $I_{AS}$                | Avalanche Current                                | 27         | A     |
| $P_D @ T_C=25^\circ C$  | Total Power Dissipation <sup>4</sup>             | 30         | W     |
| $T_{STG}$               | Storage Temperature Range                        | -55 to 150 | °C    |
| $T_J$                   | Operating Junction Temperature Range             | -55 to 150 | °C    |
| $R_{\theta JA}$         | Thermal Resistance Junction-ambient <sup>1</sup> | 50         | °C/W  |
| $R_{\theta JC}$         | Thermal Resistance Junction-Case <sup>1</sup>    | 4.6        | °C/W  |



### Electrical Characteristics( $T_J=25^{\circ}\text{C}$ unless otherwise noted)

| Symbol       | Parameter                                      | Conditions                                                   | Min. | Typ. | Max.      | Unit      |
|--------------|------------------------------------------------|--------------------------------------------------------------|------|------|-----------|-----------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V$ , $I_D=250\mu A$                                 | 30   | ---  | ---       | V         |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=10V$ , $I_D=20A$                                     | ---  | 5    | 6.3       | $m\Omega$ |
|              |                                                | $V_{GS}=4.5V$ , $I_D=15A$                                    | ---  | 6.9  | 9         |           |
| $V_{GS(th)}$ | Gate Threshold Voltage                         | $V_{GS}=V_{DS}$ , $I_D=250\mu A$                             | 1.2  | ---  | 2.5       | V         |
| $I_{DSS}$    | Drain-Source Leakage Current                   | $V_{DS}=24V$ , $V_{GS}=0V$ , $T_J=25^{\circ}\text{C}$        | ---  | ---  | 1         | $\mu A$   |
|              |                                                | $V_{DS}=24V$ , $V_{GS}=0V$ , $T_J=55^{\circ}\text{C}$        | ---  | ---  | 5         |           |
| $I_{GSS}$    | Gate-Source Leakage Current                    | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                               | ---  | ---  | $\pm 100$ | nA        |
| $g_{fs}$     | Forward Transconductance                       | $V_{DS}=5V$ , $I_D=20A$                                      | ---  | 67   | ---       | S         |
| $R_g$        | Gate Resistance                                | $V_{DS}=0V$ , $V_{GS}=0V$ , $f=1\text{MHz}$                  | ---  | 1.7  | ---       | $\Omega$  |
| $Q_g$        | Total Gate Charge (4.5V)                       | $V_{DS}=15V$ , $V_{GS}=4.5V$ , $I_D=15A$                     | ---  | 8    | ---       | nC        |
| $Q_{gs}$     | Gate-Source Charge                             |                                                              | ---  | 2.4  | ---       |           |
| $Q_{gd}$     | Gate-Drain Charge                              |                                                              | ---  | 3.2  | ---       |           |
| $T_{d(on)}$  | Turn-On Delay Time                             | $V_{DD}=15V$ , $V_{GS}=10V$ , $R_G=3.3\Omega$<br>$I_D=15A$   | ---  | 7.1  | ---       | ns        |
| $T_r$        | Rise Time                                      |                                                              | ---  | 40   | ---       |           |
| $T_{d(off)}$ | Turn-Off Delay Time                            |                                                              | ---  | 15   | ---       |           |
| $T_f$        | Fall Time                                      |                                                              | ---  | 6    | ---       |           |
| $C_{iss}$    | Input Capacitance                              | $V_{DS}=15V$ , $V_{GS}=0V$ , $f=1\text{MHz}$                 | ---  | 814  | ---       | pF        |
| $C_{oss}$    | Output Capacitance                             |                                                              | ---  | 498  | ---       |           |
| $C_{rss}$    | Reverse Transfer Capacitance                   |                                                              | ---  | 41   | ---       |           |
| $I_S$        | Continuous Source Current <sup>1,6</sup>       | $V_G=V_D=0V$ , Force Current                                 | ---  | ---  | 40        | A         |
| $V_{SD}$     | Diode Forward Voltage <sup>2</sup>             | $V_{GS}=0V$ , $I_S=1A$ , $T_J=25^{\circ}\text{C}$            | ---  | ---  | 1         | V         |
| $t_{rr}$     | Reverse Recovery Time                          | $I_F=20A$ , $di/dt=100A/\mu s$ ,<br>$T_J=25^{\circ}\text{C}$ | ---  | 15   | ---       | nS        |
| $Q_{rr}$     | Reverse Recovery Charge                        |                                                              | ---  | 25   | ---       | nC        |

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}=25V$ ,  $V_{GS}=10V$ ,  $L=0.1mH$ ,  $I_{AS}=24A$
- 4.The power dissipation is limited by 150 $^{\circ}\text{C}$  junction temperature
- 5.The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.



## Typical Characteristics

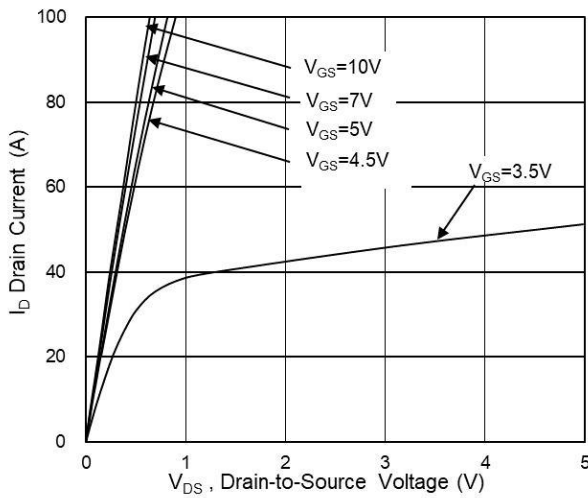


Fig.1 Typical Output Characteristics

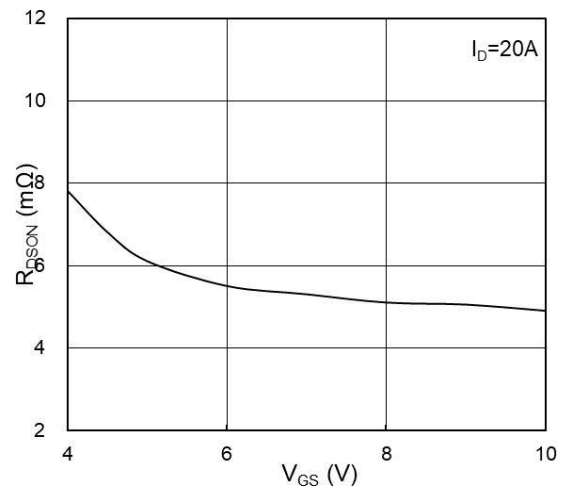


Fig.2 On-Resistance vs G-S Voltage

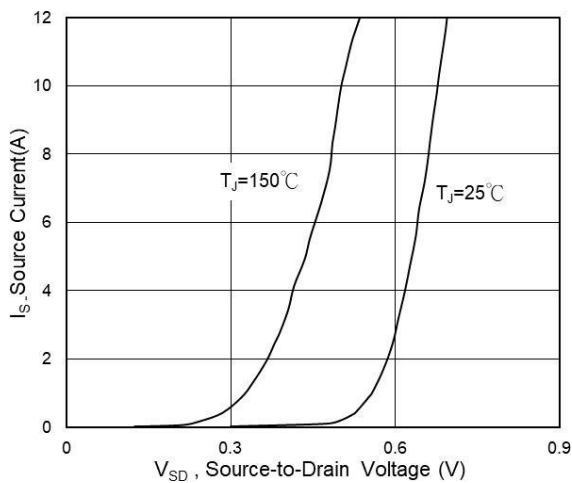


Fig.3 Source Drain Forward Characteristics

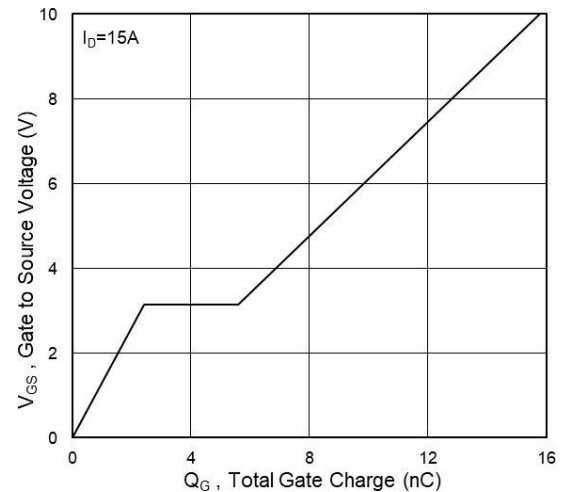


Fig.4 Gate-Charge Characteristics

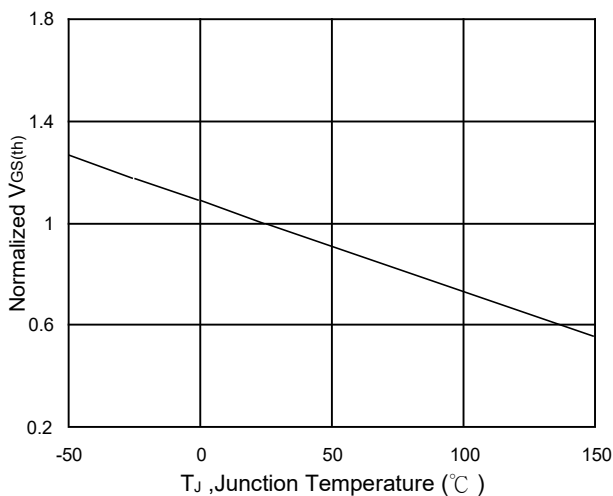


Fig.5 Normalized  $V_{GS(th)}$  vs  $T_J$

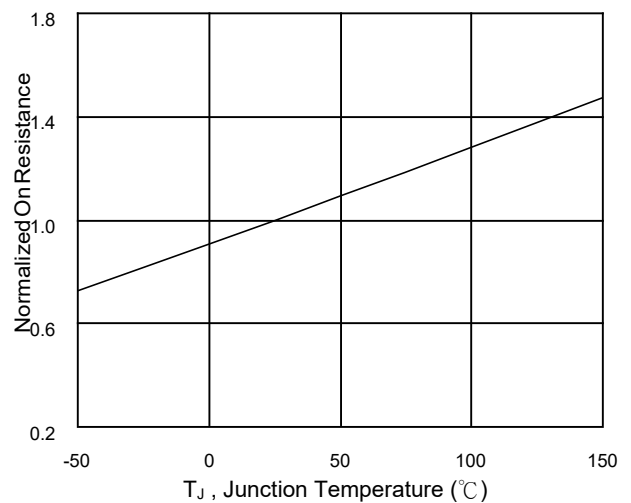


Fig.6 Normalized  $R_{DS(on)}$  vs  $T_J$

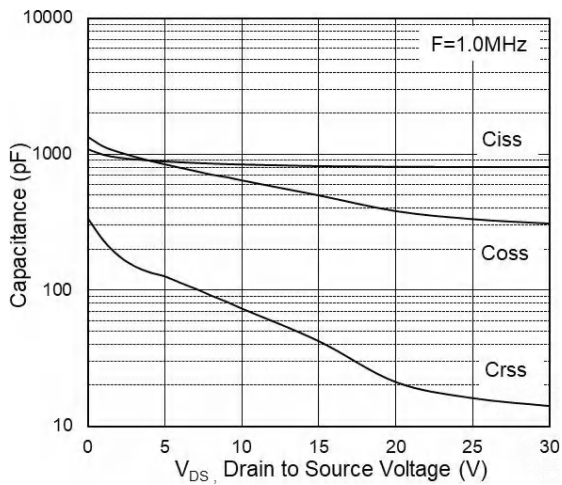


Fig.7 Capacitance

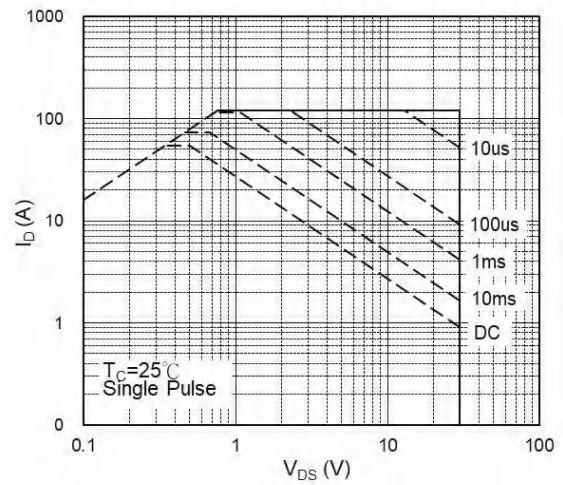


Fig.8 Safe Operating Area

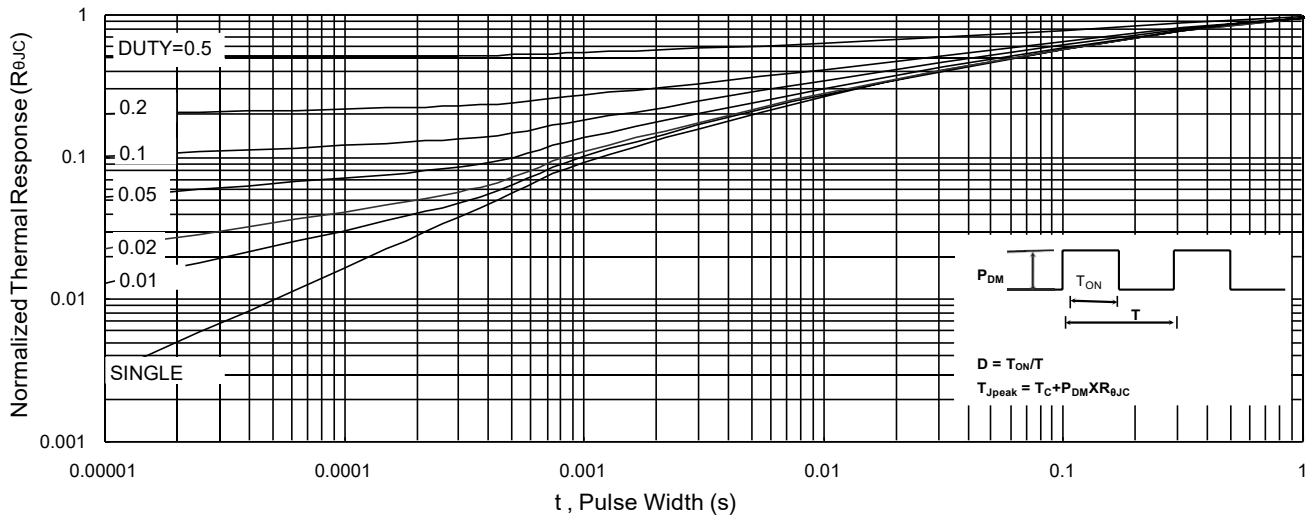


Fig.9 Normalized Maximum Transient Thermal Impedance

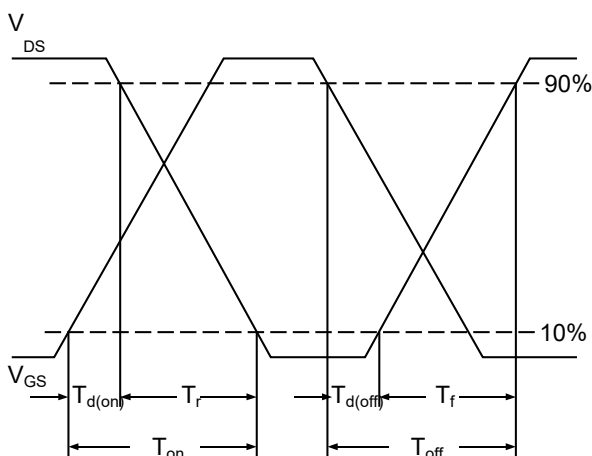


Fig.10 Switching Time Waveform

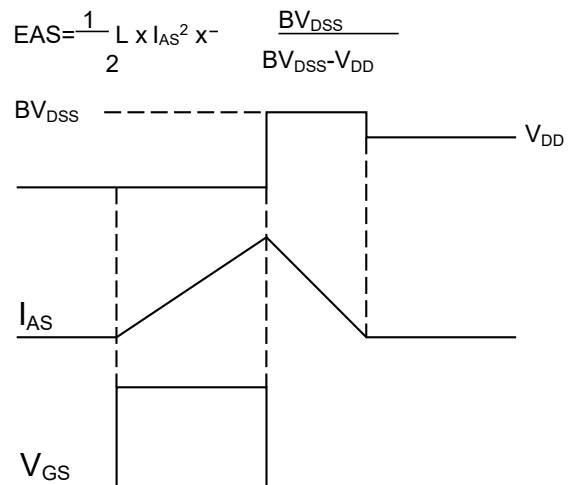
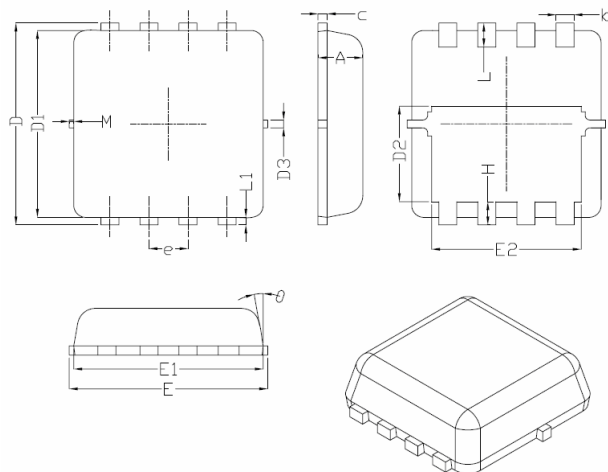


Fig.11 Unclamped Inductive Switching Waveform



## DFN3X3-8L Package Information



| Symbol | Dimensions In Millimeters |      |      |
|--------|---------------------------|------|------|
|        | Min.                      | Nom. | Max. |
| A      | 0.70                      | 0.75 | 0.80 |
| b      | 0.25                      | 0.30 | 0.35 |
| c      | 0.10                      | 0.15 | 0.25 |
| D      | 3.25                      | 3.35 | 3.45 |
| D1     | 3.00                      | 3.10 | 3.20 |
| D2     | 1.48                      | 1.58 | 1.68 |
| D3     | -                         | 0.13 | -    |
| E      | 3.20                      | 3.30 | 3.40 |
| E1     | 3.00                      | 3.15 | 3.20 |
| E2     | 2.39                      | 2.49 | 2.59 |
| e      | 0.65BSC                   |      |      |
| H      | 0.30                      | 0.39 | 0.50 |
| L      | 0.30                      | 0.40 | 0.50 |
| L1     | -                         | 0.13 | -    |
| M      | *                         | *    | 0.15 |
| θ      |                           | 10°  | 12°  |



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